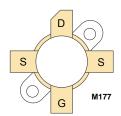


50V, 300W, 150MHz

The VRF2933 is a gold-metallized silicon n-channel RF power transistor designed for broadband commercial and military applications requiring high power and gain without compromising reliability, ruggedness, or inter-modulation distortion.



FEATURES

- Improved Ruggedness V_{(BR)DSS} = 170V
- 300W with 22dB Typ. Gain @ 30MHz, 50V
- . Excellent Stability & Low IMD
- Common Source Configuration
- · Available in Matched Pairs
- NOW 14% lower V_{DS(ON)}

- 70:1 Load VSWR Capability at Specified Operating Conditions
- Nitride Passivated
- · Refractory Gold Metallization
- Improved Replacement for SD2933
- Thermally Enhanced Package
- RoHS Compliant



Maximum Ratings All Ratings: T_c =25°C unless otherwise specified

Symbol	Parameter	VRF2933(MP)	Unit
V _{DSS}	Drain-Source Voltage	170	V
I _D	Continuous Drain Current @ T _C = 25°C	42	Α
V_{GS}	Gate-Source Voltage	±40	V
P_{D}	Total Device dissipation @ T _C = 25°C	648	W
T _{STG}	Storage Temperature Range	-65 to 150	°C
T _J	Operating Junction Temperature Max	200	

Static Electrical Characteristics

Symbol	Parameter	Min	Тур	Max	Unit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage (V _{GS} = 0V, I _D = 100mA)	170	180		V
V _{DS(ON)}	On State Drain Voltage (I _{D(ON)} = 20A, V _{GS} = 10V)		2.1	2.7	l v
I _{DSS}	Zero Gate Voltage Drain Current (V _{DS} = 100V, V _{GS} = 0V)			2.0	mA
I _{GSS}	Gate-Source Leakage Current (V _{DS} = ±20V, V _{DS} = 0V)			2.0	μA
g_{fs}	Forward Transconductance (V _{DS} = 10V, I _D = 20A)	8			mhos
V _{GS(TH)}	Gate Threshold Voltage (V _{DS} = 10V, I _D = 100mA)	2.9	3.6	4.4	V

Thermal Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.27	°C/W

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Dynamic Characteristics

V/D	ヒつのつつ	
VΓ	F2933	

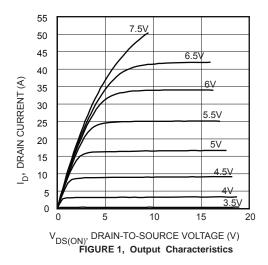
	Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Γ	C _{ISS}	Input Capacitance	V _{GS} = 0V		740		
	C _{oss}	Output Capacitance	V _{DS} = 50V		400		pF
Г	C _{rss}	Reverse Transfer Capacitance	f = 1MHz		32		

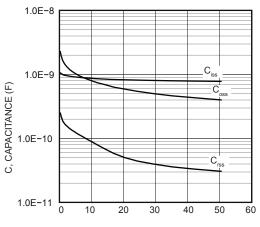
Functional Characteristics

Symbol	Parameter	Min	Тур	Max	Unit
G_{PS}	$f_1 = 30MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 300W$	20	25		dB
$\eta_{\scriptscriptstyle D}$	$f_1 = 30MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 300W CW$		50		%
Ψ	f_1 = 30MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 300W CW, 70:1 VSWR - All Phase Angles, 0.2 mSec X 20% Duty Factor	No Degradation in Output Powe		Power	

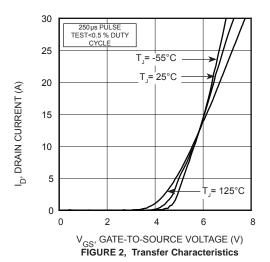
 ${\bf Microsemi\ reserves\ the\ right\ to\ change,\ without\ notice,\ the\ specifications\ and\ information\ contained\ herein.}$

Typical Performance Curves





V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)
FIGURE 3, Capacitance vs Drain-to-Source Voltage



100

(v)

IDMax

T_ = 125°C

T_ = 75°C

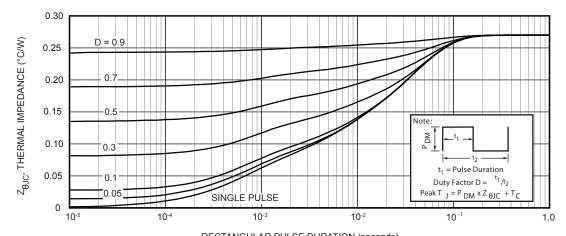
T_ = 75°C

10

 $\rm V_{DS}^{}$, DRAIN-TO-SOURCE VOLTAGE (V) FIGURE 4, Forward Safe Operating Area

100

800



RECTANGULAR PULSE DURATION (seconds)
Figure 5. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

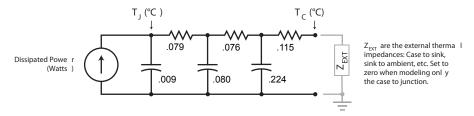
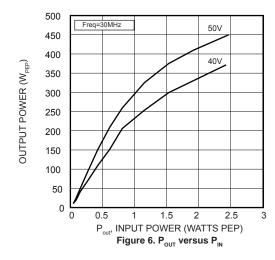


FIGURE 5b, TRANSIENT THERMAL IMPEDANCE MODEL



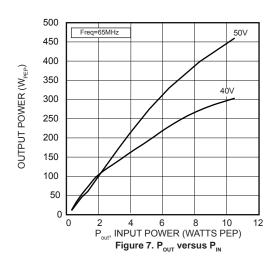


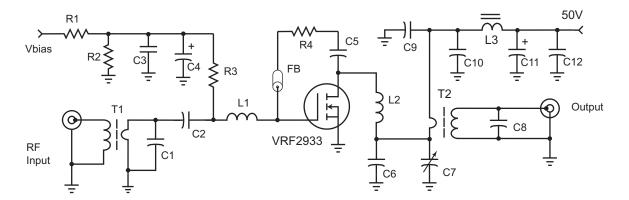
Table 1 - Typical Class AB Large Signal Input - Output Impedance

Freq. (MHz)	Z _{in}	Z _{out}
2	23.6 - j 5.5	4.0 - j 0.1
13.5	7.6 - j 10.1	3.9 - j 0.6
27.1	3.5 - j 6.0	3.7 - j 1.1
40.7	2.5 - j 4.0	3.3 - j 1.5
65	1.95 - j 2.07	2.6 - j 1.9
100	1.8 - j 0.66	1.76 - j 0.2
150	1.78 + j 0.5	1.03 + j 1.7

 $[\]mathbf{Z}_{\mathsf{IN}}$ - Gate shunted with 25 Ω

 $I_{dq} = 250 \text{mA}$

Z_{oL} - Conjugate of optimum load for 300 Watts output at V_{dd}=50V



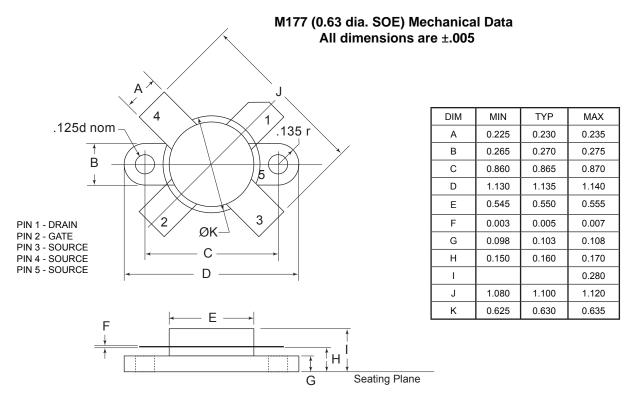
C1 1800pF ATC100B ceramic C2, C3, C5, C9, C10, C12 0.1uF 100V C6 680 pF metal clad 500V mica C7 ARCO 467 mica trimmer C8 100 pF ATC 100E ceramic C4, C11 10uF 100V Electrolytic FB small ferrite bead u_i =125 L1 20 nH 2t #18 0.188"d .2"l L2 38 nH - 2.5t #14 enam. .25" dia.

L3 2t #16 on 2x 267300081 .5" bead R1-R2 1k Ohm 1/4W R3 100 Ohm 1W R4 470 Ohm "low inductance" 3W T1 16:1 transforner 4t #20 teflon on RF Parts Co. T1/2 transformer core T2 9:1 transformer 3t #16 teflon on RF Parts Co. T1 transformer core

Adding MP at the end of P/N specifies a matched pair where $V_{\text{GS(TH)}}$ is matched between the two parts. V_{TH} values are marked on the devices per the following table.

Code	Vth Range	Code 2	Vth Range
Α	2.900 - 2.975	М	3.650 - 3.725
В	2.975 - 3.050	N	3.725 - 3.800
С	3.050 - 3.125	Р	3.800 - 3.875
D	3.125 - 3.200	R	3.875 - 3.950
E	3.200 - 3.275	S	3.950 - 4.025
F	3.275 - 3.350	Т	4.025 - 4.100
G	3.350 - 3.425	W	4.100 - 4.175
Н	3.425 - 3.500	Х	4.175 - 4.250
J	3.500 - 3.575	Υ	4.250 - 4.325
K	3.575 - 3.650	Z	4.325 - 4.400

 $[{]m V}_{_{
m TH}}$ values are based on Microsemi measurements at datasheet conditions with an accuracy of 1.0%.



HAZARDOUS MATERIAL WARNING: The ceramic portion of the device below the lead plane is beryllium oxide. Beryllium oxide dust is highly toxic when inhaled. Care must be taken during handling and mounting to avoid damage to this area. These devices must never be thrown away with general industrial or domestic waste. BeO substrate weight: 0.703g. Percentage of total module weight which is BeO: 9%.



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